



COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

Device	V _{(BR)DSS}	R _{DS(ON)} max	I _D max T _A = +25°C
Q1	60V	$85 \text{ m}\Omega @ V_{GS} = 10V$	3.1A
QΊ	60 V	120 mΩ @ V_{GS} = 4.5 V	2.7A
00	601/	150 mΩ @ $V_{GS} = -10V$	-2.4A
Q2	-60V	250 mΩ @ $V_{GS} = -4.5V$	-1.8A

Description

This new generation MOSFET has been designed to minimize the onstate resistance (R_{DS(on)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- **Power Management Functions**
- Analog Switch

Features

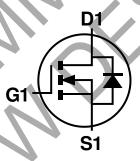
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Complementary Pair MOSFET
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

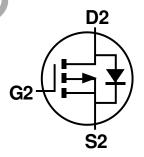
- Case: V-DFN3030-8
- Case Material: Molded Plastic, "Green" Molding Compound.
- UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Weight: 0.02 grams (approximate)



Bottom View



N-Channel MOSFET



P-Channel MOSFET

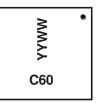
Equivalent Circuit

Ordering Information (Note 4)

Part Number	Case	Packaging
DMC6070LFDH-7	V-DFN3030-8	3,000/Tape & Reel

- No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 1. No purposely added lead. Fully EU Directive 2002/95/EC (Hohs) & 2011/05/EU (Hohs 2) compliant.
 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.</p>
 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



C60 = Product Type Marking Code YYWW = Date Code Marking YY = Last Digit of Year (ex: 12 for 2012) WW = Week Code (01 ~ 53)



Maximum Ratings Q1 N-CHANNEL (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V_{DSS}	60	V		
Gate-Source Voltage	V_{GSS}	±20	V		
Continuous Dusin Comment (Nata 5) V 40V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	3.1 2.5	А
Continuous Drain Current (Note 5) V _{GS} = 10V	$T_{A} = +25^{\circ}C$ $T_{A} = +70^{\circ}C$		ID	3.9 3.1	А
Maximum Body Diode Forward Current (Note 5)	Is	2	Α		
Pulsed Drain Current (10µs pulse, Duty cycle = 1%)	I _{DM}	15	Α		

Maximum Ratings Q2 P-CHANNEL (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V_{DSS}	-60	٧		
Gate-Source Voltage	V _{GSS}	±20	V		
Continuous Dunin Comment (Note 5) V 10)	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	lb	-2.4 -1.9	Α
Continuous Drain Current (Note 5) V _{GS} = -10V	t<10s	$T_A = +25$ °C $T_A = +70$ °C	I _D	-2.9 -2.3	Α
Maximum Body Diode Forward Current (Note 5)			Is	-2	Α
Pulsed Drain Current (10µs pulse, Duty cycle = 1%)			I _{DM}	-12	Α

Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Character	istic		Symbol	Value	Units
Total Power Dissipation (Note 5)			P_D	1.4	W
The word Desistance I has tien to Austient (Mate 5)		Steady state	Б	91	
Thermal Resistance, Junction to Ambient (Note 5		t<10s	$R_{\theta JA}$	60	°C/W
Thermal Resistance, Junction to Case (Note 5)			$R_{ heta JC}$	32	
Operating and Storage Temperature Range			T_{J}, T_{STG}	-55 to +150	°C

Note: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate

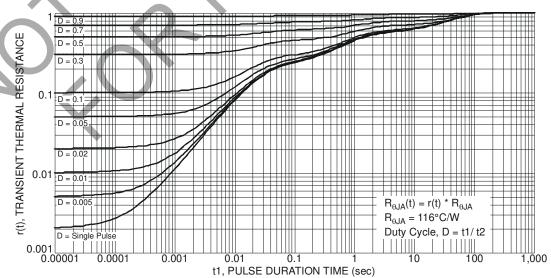


Figure 1 Transient Thermal Resistance



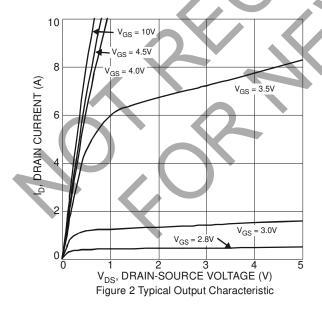


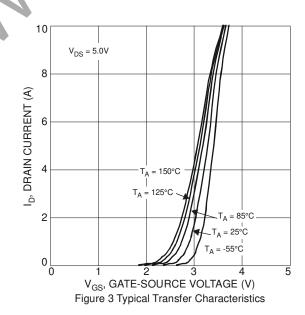
Electrical Characteristics N-CHANNEL - Q1 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)			, ,,	I		
Drain-Source Breakdown Voltage	BV _{DSS}	60	_	-	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	-	_	1	μA	$V_{DS} = 60V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	-	_	±100	nA	$V_{GS} = \pm 16V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 6)						
Gate Threshold Voltage	V _{GS(th)}	1	_	3	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
Static Drain-Source On-Resistance	D		60	85	mΩ	$V_{GS} = 10V, I_D = 1.5A$
Static Dialif-Source Off-Nesistance	R _{DS (ON)}		72	120	11122	$V_{GS} = 4.5V$, $I_D = 0.5A$
Forward Transfer Admittance	Y _{fs}	-	3.7	_	S	$V_{DS} = 5V$, $I_{D} = 1.5A$
Diode Forward Voltage	V_{SD}	-	0.7	1.2	>	$V_{GS} = 0V$, $I_S = 3A$
DYNAMIC CHARACTERISTICS (Note 7)						
Input Capacitance	C _{iss}	-	731	_	pF	V
Output Capacitance	Coss	-	34	_	pΕ	V _{DS} = 20V, V _{GS} = 0V, -f = 1MHz
Reverse Transfer Capacitance	C _{rss}	-	23	1	pF	1 - 1101112
Gate Resistance	R_g	-	1.3	-	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge (V _{GS} = 10V)	Q_g	-	11.5		nC	
Total Gate Charge (V _{GS} = 4.5V)	Q_g	-	5.2	-	nC	$V_{DS} = 30V, I_D = 3A$
Gate-Source Charge	Q_{gs}	_	2.1		nC	VDS = 30V, ID = 3A
Gate-Drain Charge	Q_{gd}	-	1.5	_	nC	
Turn-On Delay Time	t _{D(on)}	-	9.6	-	ns	
Turn-On Rise Time	tr		11	-	ns	$V_{GS} = 10V, V_{DS} = 30V,$
Turn-Off Delay Time	$t_{D(off)}$		61	_	ns	$R_G=50\Omega,R_L=20V$
Turn-Off Fall Time	t _f		21		ns	

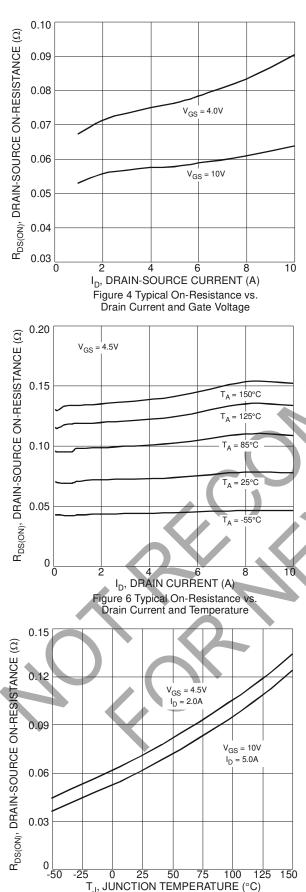
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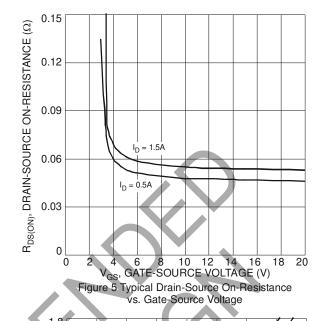
- 6. Short duration pulse test used to minimize self-heating effect 7. Guaranteed by design. Not subject to production testing

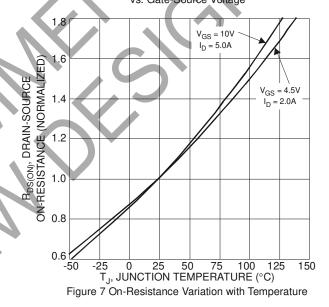












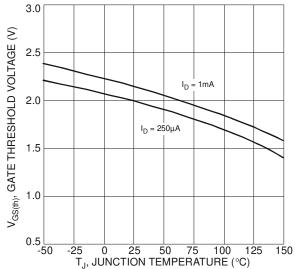
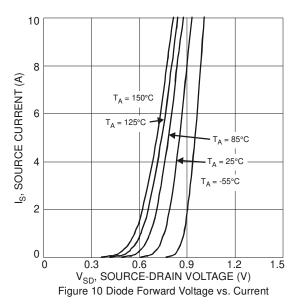
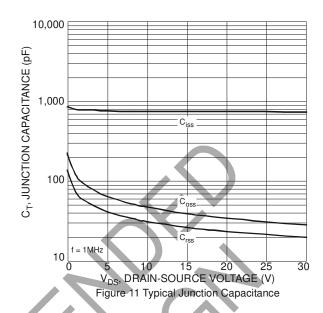


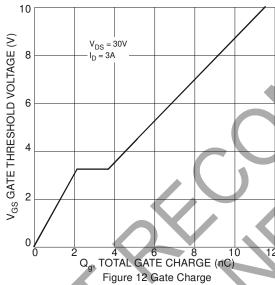
Figure 9 Gate Threshold Variation vs. Ambient Temperature

Figure 8 On-Resistance Variation with Temperature









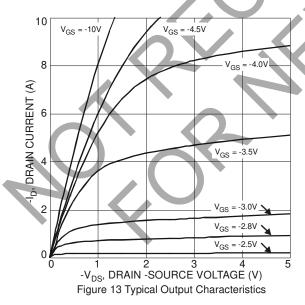


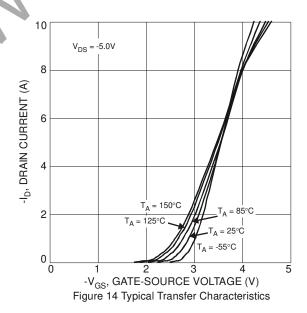
Electrical Characteristics P-CHANNEL – Q2 (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	-60	_	-	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	-	-	-1	μΑ	$V_{DS} = -60V, V_{GS} = 0V$
Gate-Source Leakage	IGSS	-	_	±100	nA	$V_{GS} = \pm 16V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	$V_{GS(th)}$	-1	_	-3	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
Static Drain-Source On-Resistance	D		115	150	mΩ	$V_{GS} = -10V, I_D = -1A$
Static Drain-Source On-Nesistance	R _{DS (ON)}	_	170	250	11122	$V_{GS} = -4.5V$, $I_D = -0.5A$
Forward Transfer Admittance	Y _{fs}	-	2.8		S	$V_{DS} = -5V, I_{D} = -1A$
Diode Forward Voltage	V_{SD}	-	-0.7	-1.2	V	$V_{GS} = 0V, I_{S} = -2A$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	-	612	-	pF	201/1/
Output Capacitance	Coss	-	36	-	рF	$V_{DS} = -20V, V_{GS} = 0V,$ f = 1MHz
Reverse Transfer Capacitance	Crss	-	26	-	рF	1 = 1101112
Gate Resistance	R_g	-	13_		Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge (V _{GS} = -10V)	Q_g	-	8.9		nC	
Total Gate Charge (V _{GS} = -4.5V)	Q_g	-	4.3		nC	$V_{DS} = -30V$, $I_{D} = -2A$
Gate-Source Charge	Q_{gs}	-	1.4		nC	$V_{DS} = -30V, I_{D} = -2A$
Gate-Drain Charge	Q_{gd}	-	1.7	_	nC	
Turn-On Delay Time	t _{D(on)}	-	7.6	=	ns	
Turn-On Rise Time	t _r	-	11.6	-	ns	$V_{GS} = -10V, V_{DS} = -30V,$
Turn-Off Delay Time	$t_{D(off)}$		79.8	_	ns	$R_G = 50\Omega, I_D = -1A$
Turn-Off Fall Time	t _f	-	37.8	-	ns	

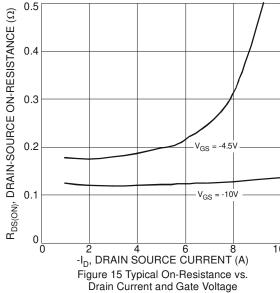
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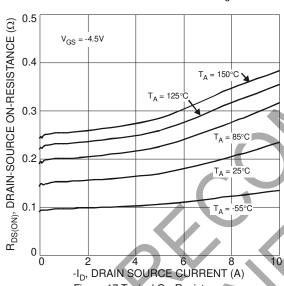
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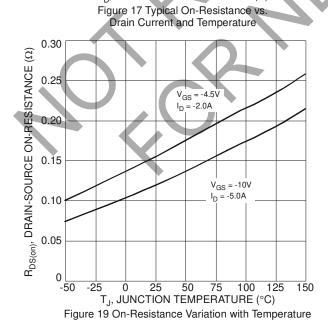


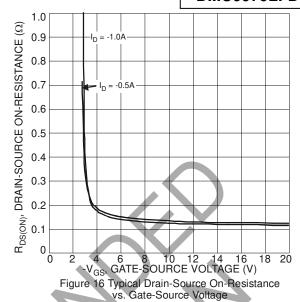


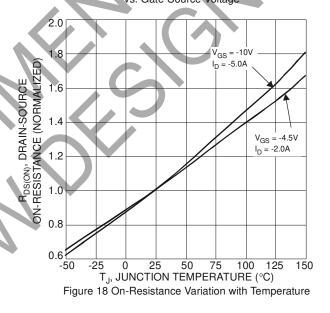












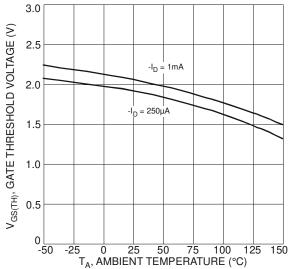
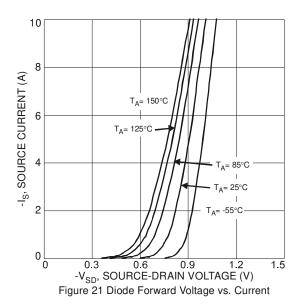
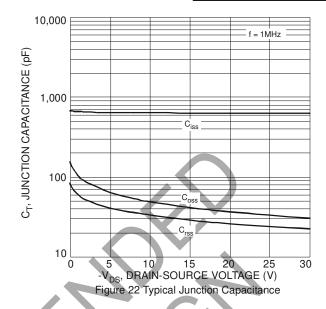
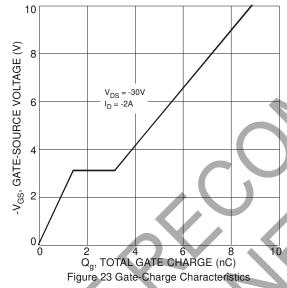


Figure 20 Gate Threshold Variation vs. Ambient Temperature





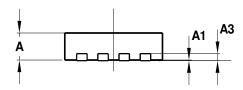


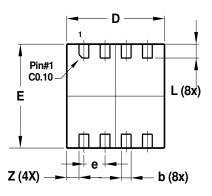




Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.

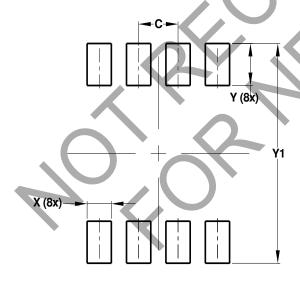




	V-DFN3030-8					
Dim	Min	Max	Тур			
Α	0.75	0.85	0.80			
A1	0	0.05	0.02			
A3	-	-	0.203			
b	0.25	0.35	0.30			
D	2.95	3.05	3.00			
Ε,	2.95	3.05	3.00			
е		//-	0.65			
-1	0.55	0.65	0.60			
Z		_	0.375			
All Dimensions in mm						

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
С	0.650
Х	0.400
Υ	0.850
V1	2 400

Not recommended for new design



DMC6070LFDH

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